## Notice of References Cited Application/Control No. O9/802,223 Reexamination KEITH, CHRISTOPHER Examiner Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0004774	01-2002	Defarlo, Tony	705/36
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## NON-PATENT DOCUMENTS

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